

# **Product Data Sheet for Reference Material**

# RC11/08

Aluminium Base (Type of Standard) setting up sample

# **Indicative Values**

Element	Mass content [%]
Silicon (Si)	(0.028)
Iron (Fe)	(0.045)
Copper (Cu)	(0.015)
Manganese (Mn)	(0.016)
Magnesium (Mg)	(0.017)
Chromium (Cr)	(0.013)
Nickel (Ni)	(0.010)
Zinc (Zn)	(0.018)
Titanium (Ti)	(0.016)
Silver (Ag)	(0.010)
Arsenic (As)	(0.0036)
Barium (Ba)	(0.0074)
Beryllium (Be)	(0.0015)
Bismuth (Bi)	(0.010)
Calcium (Ca)	(0.0016)
Cadmium (Cd)	(0.0049)
Cerium (Ce)	(0.0020)
Cobalt (Co)	(0.013)
Gallium (Ga)	(0.021)
Mercury (Hg)	(0.0045)
Indium (In)	(0.010)
Lanthanum (La)	(0.012)
Lithium (Li)	(0.0004)
Molybdenum (Mo)	(0.033)
Sodium (Na)	(0.0017)
Phosphorus (P)	(0.0020)
Lead (Pb)	(0.014)
Antimony (Sb)	(0.013)
Scandium (Sc)	(0.0093)
Tin (Sn)	(0.016)
Strontium (Sr)	(0.0050)
Vanadium (V)	(0.016)
Tungsten (W)	(0.0044)
Zirconium (Zr)	(0.015)

Values in brackets ( ) are not certified but given for information only.

## Manufacturing

This setting up sample is produced using six strand hot top vertical continuous casting out of single melt.

# Homogeneity

Homogeneity testing is performed by means of spark emission spectroscopy. Tests involve making multiple measurements on individual samples taken at regular intervals along the entire length of each cast rod. Depending on the mass content of the element, the relative standard deviation of 10 to 20 measurements within one disc is influenced by the material homogeneity and stability of the

measurement instrument and is typically found to be as shown in the following table. Homogeneity in between discs of the same cast is not specified.

Table 1: Sample homogeneity for different elements in the reference material.

elements with concentration 0.01 % - 0.5 %	< 2 % relative standard deviation
elements with concentration < 0.01 %	< 5 % relative standard deviation
elements: As, Ce	5 % - 25 % relative standard deviation

### **Analysis**

The homogeneity analysis of this material was performed in our ISO/IEC 17025 accredited analytical laboratory (STS 0023) by spark optical emission spectroscopy. This is a setting up sample. Only homogeneity of this standard is analyzed. No concentration values are certified. The values given in brackets have been determined using spark source optical emission spectroscopy.

### **Description of Sample**

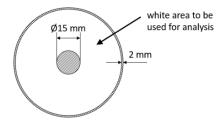
This setting up sample is available in the form of discs (approx. Ø 60 x 40 mm).

#### Intended use and Stability

This setting up sample is primarily intended for use in spark optical emission spectroscopy. Other applications are X-ray fluorescence spectrometry (XRF). The material will remain stable for the period given below (data sheet validity) if it is stored in a dry (non-condensing) and clean environment at room temperature (≤40 °C).

#### Instructions for Use

Measurements should be made within a ring (see white area in the picture). For spark OES analysis, the surface of the material needs to be prepared by milling. The minimum area to be analyzed for spark OES and XRF analysis is 30 mm<sup>2</sup>. This reference material shall mainly be used for drift correction. The values within one disc may be regarded as constant for this purpose. For a new disc of the same material the values may slightly differ and this should be taken into account (check operator manual of your system).



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